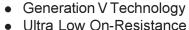
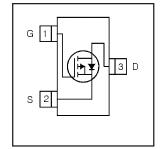


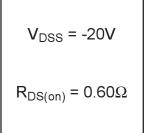
IRLML6302PbF

HEXFET® Power MOSFET



- Ollia Low Oil-Resistai
- P-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching
- Lead-Free





Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

A customized leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards.



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ -4.5V	-0.78	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ -4.5V	-0.62	Α
I _{DM}	Pulsed Drain Current ①	-4.9	
P _D @T _A = 25°C	Power Dissipation	540	mW
	Linear Derating Factor	4.3	mW/°C
V_{GS}	Gate-to-Source Voltage	± 12	V
dv/dt	Peak Diode Recovery dv/dt ②	-5.0	V/ns
T _{J,} T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{eJA}	Maximum Junction-to-Ambient ④		230	°C/W



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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-20			V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-4.9		mV/°C	Reference to 25°C, I _D = -1mA
В	Static Drain-to-Source On-Resistance			0.60		V _{GS} = -4.5V, I _D = -0.61A ③
R _{DS(ON)}	Static Drain-to-Source On-Resistance			0.90	Ω	V _{GS} = -2.7V, I _D = -0.31A ③
V _{GS(th)}	Gate Threshold Voltage	-0.70		-1.5	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
g _{fs}	Forward Transconductance	0.56			S	$V_{DS} = -10V, I_D = -0.31A$
I _{DSS}	Drain-to-Source Leakage Current			-1.0	μΑ	V_{DS} = -16V, V_{GS} = 0V
IDSS	Brain-to-oddroc Ecanage Garrent			-25	μΑ	V _{DS} = -16V, V _{GS} = 0V, T _J = 125°C
I _{GSS}	Gate-to-Source Forward Leakage			-100	nA	$V_{GS} = -12V$
'GSS	Gate-to-Source Reverse Leakage			100	''^	$V_{GS} = 12V$
Qg	Total Gate Charge		2.4	3.6		$I_D = -0.61A$
Q _{gs}	Gate-to-Source Charge		0.56	0.84	nC	$V_{DS} = -16V$
Q _{gd}	Gate-to-Drain ("Miller") Charge		1.0	1.5		V_{GS} = -4.5V, See Fig. 6 and 9 ③
t _{d(on)}	Turn-On Delay Time		13			$V_{DD} = -10V$
t _r	Rise Time		18		ns	$I_D = -0.61A$
t _{d(off)}	Turn-Off Delay Time		22		115	$R_G = 6.2\Omega$
t _f	Fall Time		22		Ī	$R_D = 16\Omega$, See Fig. 10 ③
C _{iss}	Input Capacitance		97			V _{GS} = 0V
C _{oss}	Output Capacitance		53		pF	V _{DS} = -15V
C _{rss}	Reverse Transfer Capacitance		28			f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			0.54		MOSFET symbol
	(Body Diode)			-0.54	A	showing the
I _{SM}	Pulsed Source Current			-4.9	_ ^	integral reverse
	(Body Diode) ①			-4.5		p-n junction diode.
V _{SD}	Diode Forward Voltage			-1.2	V	T _J = 25°C, I _S = -0.61A, V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		35	53	ns	$T_J = 25^{\circ}C$, $I_F = -0.61A$
Q _{rr}	Reverse Recovery Charge		26	39	nC	di/dt = -100A/µs ⊕

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} \mathbb{Q} & I_{SD} \leq -0.61A, \ di/dt \leq 76A/\mu s, \ V_{DD} \!\! \leq \!\! V_{(BR)DSS}, \\ & T_J \! \leq \! 150^{\circ}C \end{tabular}$
- 4 Surface mounted on FR-4 board, $t \leq 5 sec.$